

Notice of References Cited	Application/Control No. 10/617,690	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner William J. Deane	Art Unit 2642	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	U.S. Patent Application No. 2004/0162036 (Park), 08-2004
	V	U.S. Patent Application No. 2003/0155216 (Park et al.), 08-2003
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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